



Form PT-449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
M122-1350SERIAL NO.
09/687,600

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APPLICANT
Micron Technology, Inc.FILING DATE
October 12, 2000GROUP
3724

U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
h	AA	4,807,504	2/28/89	Vandermarliere			
h	AB	4,822,015	4/18/89	Glasman et al.			
h	AC	5,063,800	11/12/91	Jung et al.			
h	AD	5,288,061	2/22/94	Pieroni			
h	AE	5,970,606	10/26/99	Buechele			
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
W	AA	5,173,766	12/22/92	Long et al.	—	—	
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